

DIM1600ECM17-A000

IGBT Chopper Module

DS6069-1 September 2011 (LN28672)

FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- Isolated AISiC Base with AIN Substrates
- Lead Free Construction

APPLICATIONS

- Motor Controllers
- Power Supplies
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM1600ECM17-A000 is a 1700V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) chopper module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM1600ECM17-A000

Note: When ordering, please use the complete part number

KEY PARAMETERS

V _{CES}		1700V
V _{CE(sat)}	* (typ)	2.7V
l _c ` ´	(max)	1600A
$I_{C(PK)}$	(max)	3200A

^{*} Measured at the auxiliary terminals

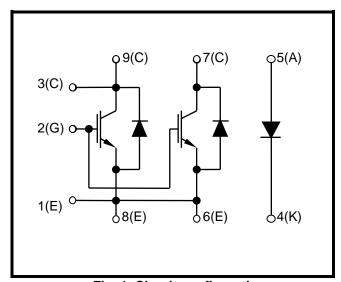


Fig. 1 Circuit configuration



Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V$	1700	V
V_{GES}	Gate-emitter voltage		±20	V
I _C	Continuous collector current	$T_{case} = 75^{\circ}C$	1600	Α
$I_{C(PK)}$	Peak collector current	1ms, T _{case} = 110°C	3200	Α
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	13900	W
l ² t	Diode I ² t value (IGBT arm)	480	kA ² s	
Ιt	Diode I ² t value (Diode arm)	$V_R = 0$, $t_p = 10$ ms, $T_j = 125$ °C		kA ² s
V _{isol}	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	4000	V
Q_PD	Partial discharge – per module	IEC1287, V ₁ = 1800V, V ₂ = 1300V, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

33mm

20mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor (per arm)	Continuous dissipation – junction to case	1	-	9	°C/kW
_	Thermal resistance – diode (IGBT arm)	Continuous dissipation – junction to case	-	-	20	°C/kW
$R_{th(j-c)}$	Thermal resistance – diode (Diode arm)		-	-	20	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	6	°C/kW
_	Junction temperature	Transistor	-	-	150	°C
T _j		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M6	-	-	5	Nm
		Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
_	Collector cut-off current	$V_{GE} = 0V$, $V_{CE} = V_{CES}$			2	mA
I _{CES}		$V_{GE} = 0V$, $V_{CE} = V_{CES}$, $T_{case} = 125$ °C			50	mA
I _{GES}	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			8	μA
V _{GE(TH)}	Gate threshold voltage	$I_C = 80$ mA, $V_{GE} = V_{CE}$	4.5	5.5	6.5	V
\/ †	Collector-emitter saturation	V _{GE} = 15V, I _C = 1600A		2.7	3.2	V
$V_{CE(sat)}^{\dagger}$	voltage	V _{GE} = 15V, I _C = 1600A, T _j = 125°C		3.4	4.0	V
I _F	Diode forward current	DC		1600		Α
I _{FM}	Diode maximum forward current	$t_p = 1 ms$		3200		Α
	Diode forward voltage (IGBT arm)	I _F = 1600A		2.2	2.5	V
V_F^{\dagger}	Diode forward voltage (Diode arm)			2.2	2.5	V
	Diode forward voltage (IGBT arm)	- I _F = 1600A, T _j = 125°C		2.3	2.6	V
	Diode forward voltage (Diode arm)			2.3	2.6	V
C _{ies}	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		120		nF
Q_g	Gate charge	±15V		18		μC
C_{res}	Reverse transfer capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz				nF
L _M	Module inductance – IGBT arm			15		nΗ
R _{INT}	Internal resistance – IGBT arm			140		μΩ
SC _{Data}	Short circuit current, I _{SC}	$T_{j} = 125^{\circ}C$, $V_{CC} = 1000V$ $t_{p} \le 10\mu s$, $V_{GE} \le 15V$ $V_{CE (max)} = V_{CES} - L^{*}x dI/dt$ IEC 60747-9		6400		А

 $^{^{\}dagger}$ Measured at the auxiliary terminals $^{\cdot}$ L is the circuit inductance + L_{M}

ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	$I_{C} = 1600A$ $V_{GF} = \pm 15V$		1400		ns
t _f	Fall time			200		ns
E _{OFF}	Turn-off energy loss	$V_{GE} = £13V$ $V_{CE} = 900V$		500		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 1.5\Omega$ $R_{G(OFF)} = 1.5\Omega$ $L_S \sim 100 \text{nH}$		300		ns
t _r	Rise time			200		ns
E _{ON}	Turn-on energy loss			300		mJ
Q_{rr}	Diode reverse recovery charge	I _E = 1600A		400		μC
I _{rr}	Diode reverse recovery current	V _{CE} = 900V		1000		Α
E _{rec}	Diode reverse recovery energy	dl _F /dt = 8000A/µs		200		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 1600A		1600		ns
t _f	Fall time			250		ns
E _{OFF}	Turn-off energy loss	$V_{GE} = \pm 15V$ $V_{CE} = 900V$		650		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 1.5\Omega$ $R_{G(OFF)} = 1.5\Omega$ $L_S \sim 100 \text{nH}$		400		ns
t _r	Rise time			250		ns
E _{ON}	Turn-on energy loss			600		mJ
Q _{rr}	Diode reverse recovery charge	$I_F = 1600A$ $V_{CE} = 900V$ $dI_F/dt = 7000A/\mu s$		600		μC
I _{rr}	Diode reverse recovery current			1050		Α
E _{rec}	Diode reverse recovery energy			400		mJ

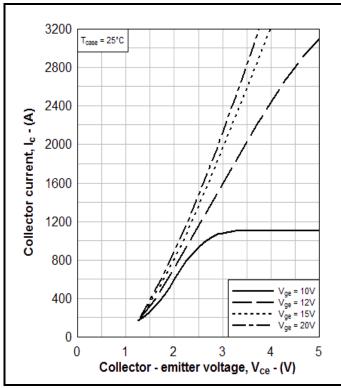


Fig. 3 Typical output characteristics

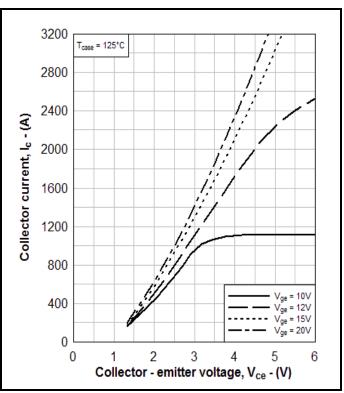


Fig. 4 Typical output characteristics

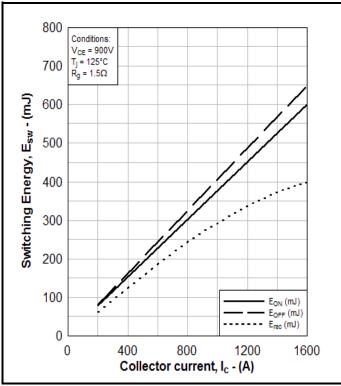


Fig. 5 Typical switching energy vs collector current

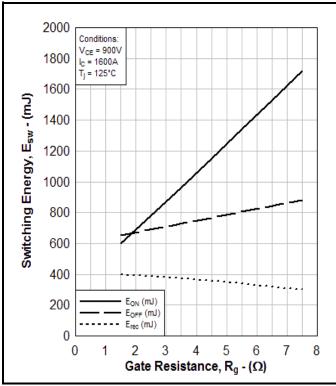


Fig. 6 Typical switching energy vs gate resistance

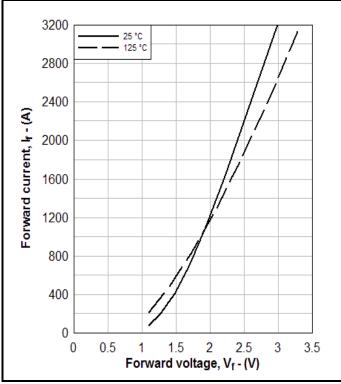


Fig. 7 Diode typical forward characteristics

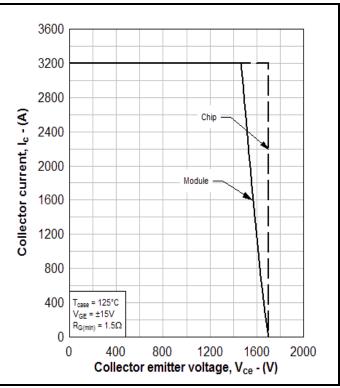


Fig. 8 Reverse bias safe operating area

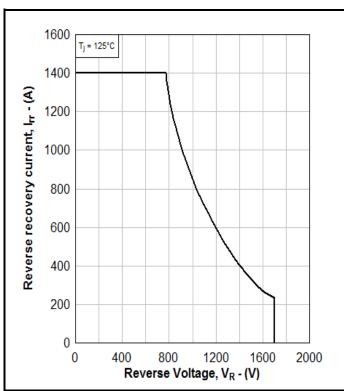


Fig. 9 Diode reverse bias safe operating area

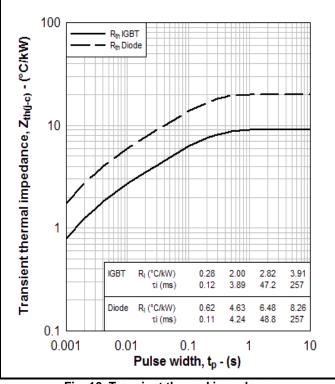


Fig. 10 Transient thermal impedance

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

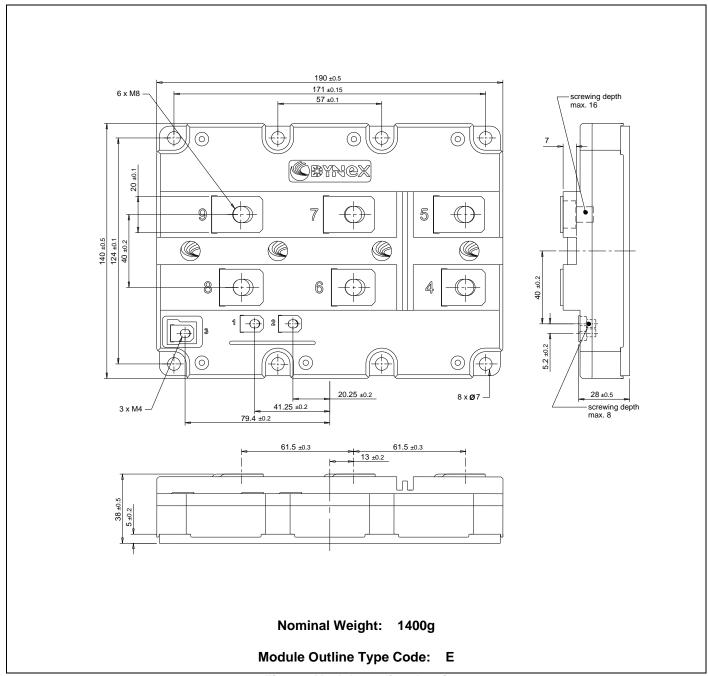


Fig. 11 Module outline drawing

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